



Welcome to [E-XFL.COM](https://www.e-xfl.com)

### Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### Details

Product Status	Obsolete
Number of LABs/CLBs	384
Number of Logic Elements/Cells	1728
Total RAM Bits	32768
Number of I/O	98
Number of Gates	57906
Voltage - Supply	2.375V ~ 2.625V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	144-LQFP
Supplier Device Package	144-TQFP (20x20)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xcv50-4tq144i">https://www.e-xfl.com/product-detail/xilinx/xcv50-4tq144i</a>

### Virtex Device/Package Combinations and Maximum I/O

Table 3: Virtex Family Maximum User I/O by Device/Package (Excluding Dedicated Clock Pins)

Package	XCV50	XCV100	XCV150	XCV200	XCV300	XCV400	XCV600	XCV800	XCV1000
CS144	94	94							
TQ144	98	98							
PQ240	166	166	166	166	166				
HQ240						166	166	166	
BG256	180	180	180	180					
BG352			260	260	260				
BG432					316	316	316	316	
BG560						404	404	404	404
FG256	176	176	176	176					
FG456			260	284	312				
FG676						404	444	444	
FG680							512	512	512

### Virtex Ordering Information

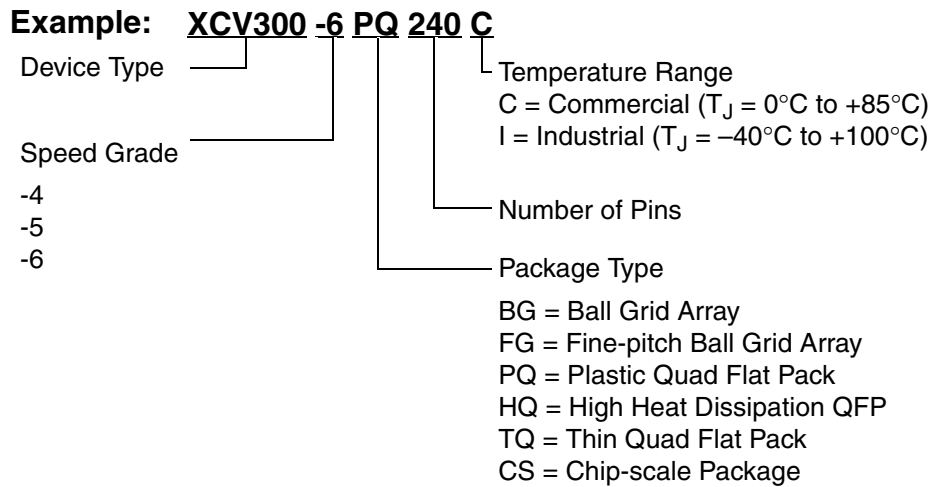


Figure 1: Virtex Ordering Information

more I/O pins convert to  $V_{REF}$  pins. Since these are always a superset of the  $V_{REF}$  pins used for smaller devices, it is possible to design a PCB that permits migration to a larger device if necessary. All the  $V_{REF}$  pins for the largest device anticipated must be connected to the  $V_{REF}$  voltage, and not used for I/O.

In smaller devices, some  $V_{CCO}$  pins used in larger devices do not connect within the package. These unconnected pins can be left unconnected externally, or can be connected to the  $V_{CCO}$  voltage to permit migration to a larger device if necessary.

In TQ144 and PQ/HQ240 packages, all  $V_{CCO}$  pins are bonded together internally, and consequently the same  $V_{CCO}$  voltage must be connected to all of them. In the CS144 package, bank pairs that share a side are interconnected internally, permitting four choices for  $V_{CCO}$ . In both cases, the  $V_{REF}$  pins remain internally connected as eight banks, and can be used as described previously.

## Configurable Logic Block

The basic building block of the Virtex CLB is the logic cell (LC). An LC includes a 4-input function generator, carry logic, and a storage element. The output from the function generator in each LC drives both the CLB output and the D input of the flip-flop. Each Virtex CLB contains four LCs, organized in two similar slices, as shown in Figure 4.

Figure 5 shows a more detailed view of a single slice.

In addition to the four basic LCs, the Virtex CLB contains logic that combines function generators to provide functions

of five or six inputs. Consequently, when estimating the number of system gates provided by a given device, each CLB counts as 4.5 LCs.

## Look-Up Tables

Virtex function generators are implemented as 4-input look-up tables (LUTs). In addition to operating as a function generator, each LUT can provide a 16 x 1-bit synchronous RAM. Furthermore, the two LUTs within a slice can be combined to create a 16 x 2-bit or 32 x 1-bit synchronous RAM, or a 16x1-bit dual-port synchronous RAM.

The Virtex LUT can also provide a 16-bit shift register that is ideal for capturing high-speed or burst-mode data. This mode can also be used to store data in applications such as Digital Signal Processing.

## Storage Elements

The storage elements in the Virtex slice can be configured either as edge-triggered D-type flip-flops or as level-sensitive latches. The D inputs can be driven either by the function generators within the slice or directly from slice inputs, bypassing the function generators.

In addition to Clock and Clock Enable signals, each Slice has synchronous set and reset signals (SR and BY). SR forces a storage element into the initialization state specified for it in the configuration. BY forces it into the opposite state. Alternatively, these signals can be configured to operate asynchronously. All of the control signals are independently invertible, and are shared by the two flip-flops within the slice.

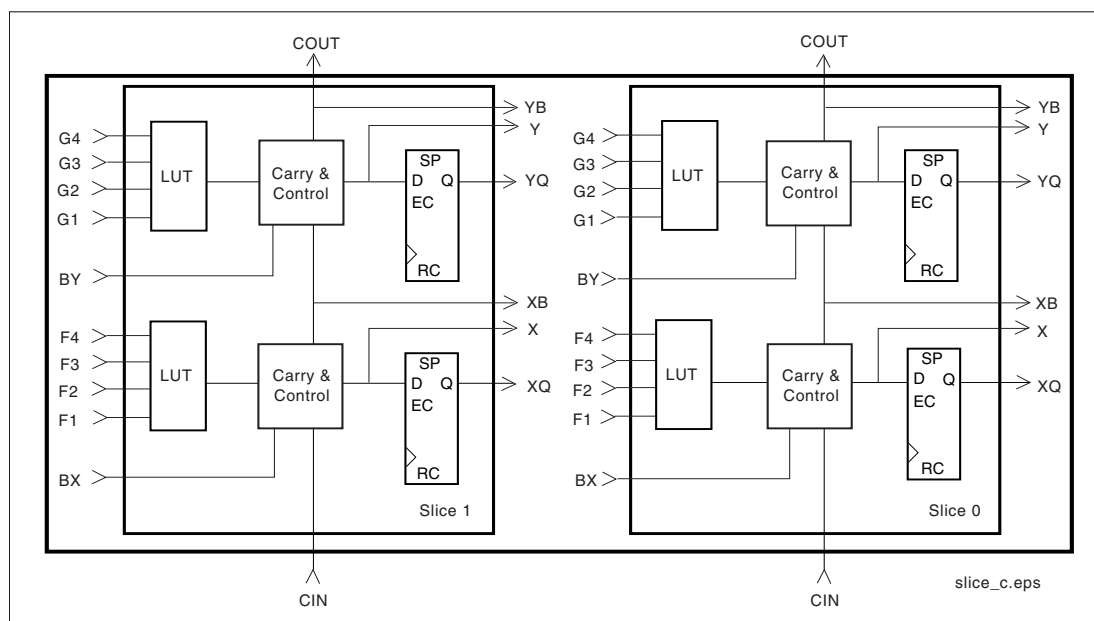


Figure 4: 2-Slice Virtex CLB

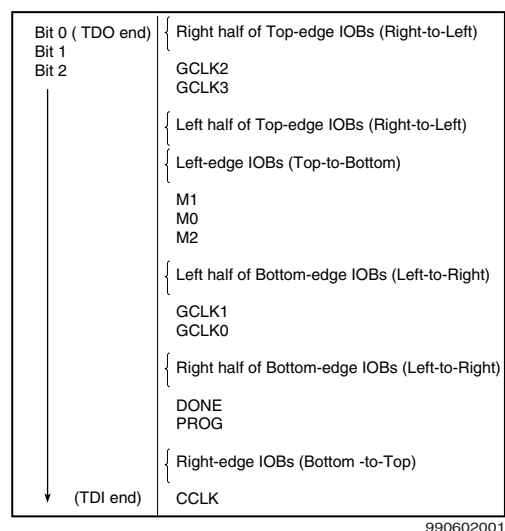


Figure 11: Boundary Scan Bit Sequence

Table 5: Boundary Scan Instructions

Boundary-Scan Command	Binary Code(4:0)	Description
EXTEST	00000	Enables boundary-scan EXTEST operation
SAMPLE/PRELOAD	00001	Enables boundary-scan SAMPLE/PRELOAD operation
USER 1	00010	Access user-defined register 1
USER 2	00011	Access user-defined register 2
CFG_OUT	00100	Access the configuration bus for read operations.
CFG_IN	00101	Access the configuration bus for write operations.
INTEST	00111	Enables boundary-scan INTEST operation
USERCODE	01000	Enables shifting out USER code
IDCODE	01001	Enables shifting out of ID Code
HIGHZ	01010	3-states output pins while enabling the Bypass Register
JSTART	01100	Clock the start-up sequence when StartupClk is TCK
BYPASS	11111	Enables BYPASS
RESERVED	All other codes	Xilinx reserved instructions

## Identification Registers

The IDCODE register is supported. By using the IDCODE, the device connected to the JTAG port can be determined.

The IDCODE register has the following binary format:

vvvv:ffff:ffa:aaaa:aaaa:cccc:cccc:ccc1

where

v = the die version number

f = the family code (03h for Virtex family)

a = the number of CLB rows (ranges from 010h for XCV50 to 040h for XCV1000)

c = the company code (49h for Xilinx)

The USERCODE register is supported. By using the USER-CODE, a user-programmable identification code can be loaded and shifted out for examination. The identification code is embedded in the bitstream during bitstream generation and is valid only after configuration.

Table 6: IDCODEs Assigned to Virtex FPGAs

FPGA	IDCODE
XCV50	v0610093h
XCV100	v0614093h
XCV150	v0618093h
XCV200	v061C093h
XCV300	v0620093h
XCV400	v0628093h
XCV600	v0630093h
XCV800	v0638093h
XCV1000	v0640093h

## Including Boundary Scan in a Design

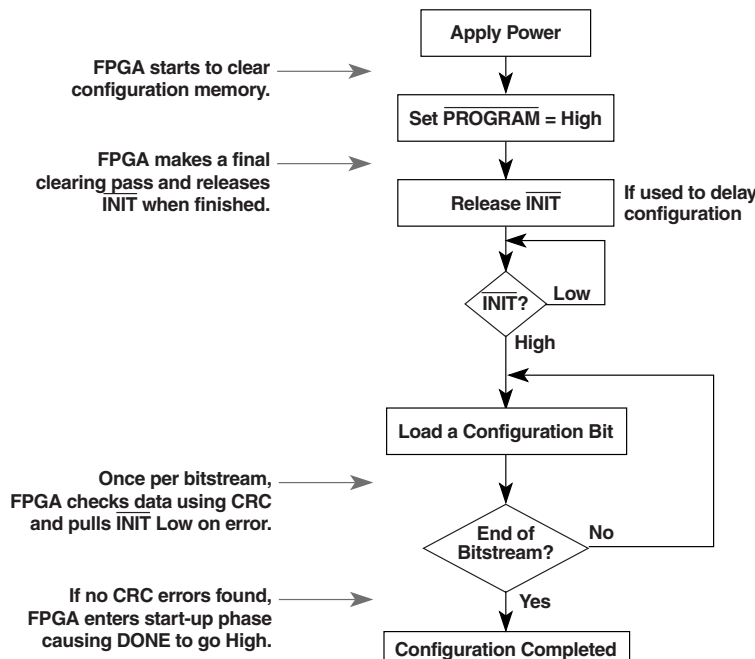
Since the boundary scan pins are dedicated, no special element needs to be added to the design unless an internal data register (USER1 or USER2) is desired.

If an internal data register is used, insert the boundary scan symbol and connect the necessary pins as appropriate.

## Development System

Virtex FPGAs are supported by the Xilinx Foundation and Alliance CAE tools. The basic methodology for Virtex design consists of three interrelated steps: design entry, implementation, and verification. Industry-standard tools are used for design entry and simulation (for example, Synopsys FPGA Express), while Xilinx provides proprietary architecture-specific tools for implementation.

The Xilinx development system is integrated under the Xilinx Design Manager (XDM™) software, providing design-



ds003\_154\_111799

Figure 15: Serial Configuration Flowchart

After configuration, the pins of the SelectMAP port can be used as additional user I/O. Alternatively, the port can be retained to permit high-speed 8-bit readback.

Retention of the SelectMAP port is selectable on a design-by-design basis when the bitstream is generated. If retention is selected, PROHIBIT constraints are required to prevent the SelectMAP-port pins from being used as user I/O.

Multiple Virtex FPGAs can be configured using the SelectMAP mode, and be made to start-up simultaneously. To configure multiple devices in this way, wire the individual CCLK, Data, WRITE, and BUSY pins of all the devices in parallel. The individual devices are loaded separately by asserting the CS pin of each device in turn and writing the appropriate data. see Table 9 for SelectMAP Write Timing Characteristics.

Table 9: SelectMAP Write Timing Characteristics

	Description		Symbol		Units
CCLK	D <sub>0-7</sub> Setup/Hold	1/2	T <sub>SMDCC</sub> /T <sub>SMCCD</sub>	5.0 / 1.7	ns, min
	$\overline{\text{CS}}$ Setup/Hold	3/4	T <sub>SMCSCC</sub> /T <sub>SMCCCS</sub>	7.0 / 1.7	ns, min
	$\overline{\text{WRITE}}$ Setup/Hold	5/6	T <sub>SMCCW</sub> /T <sub>SMWCC</sub>	7.0 / 1.7	ns, min
	BUSY Propagation Delay	7	T <sub>SMCKBY</sub>	12.0	ns, max
	Maximum Frequency		F <sub>CC</sub>	66	MHz, max
	Maximum Frequency with no handshake		F <sub>CCNH</sub>	50	MHz, max

### Write

Write operations send packets of configuration data into the FPGA. The sequence of operations for a multi-cycle write operation is shown below. Note that a configuration packet can be split into many such sequences. The packet does not have to complete within one assertion of  $\overline{\text{CS}}$ , illustrated in Figure 16.

1. Assert  $\overline{\text{WRITE}}$  and  $\overline{\text{CS}}$  Low. Note that when  $\overline{\text{CS}}$  is asserted on successive CCLKs,  $\overline{\text{WRITE}}$  must remain either asserted or de-asserted. Otherwise an abort will be initiated, as described below.
2. Drive data onto D[7:0]. Note that to avoid contention, the data source should not be enabled while  $\overline{\text{CS}}$  is Low and  $\overline{\text{WRITE}}$  is High. Similarly, while  $\overline{\text{WRITE}}$  is High, no more than one  $\overline{\text{CS}}$  should be asserted.

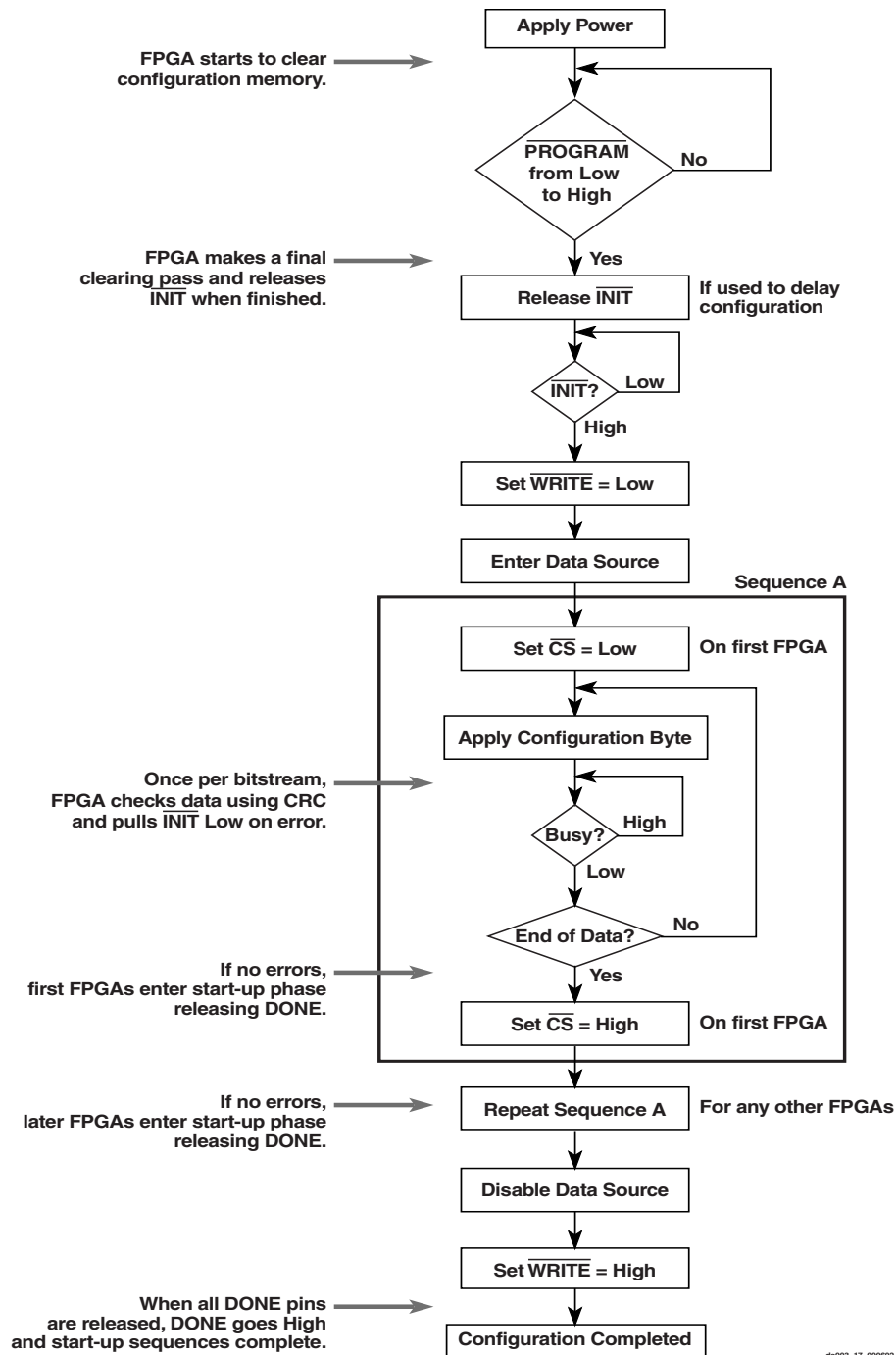


Figure 17: SelectMAP Flowchart for Write Operation

### Abort

During a given assertion of  $\overline{CS}$ , the user cannot switch from a write to a read, or vice-versa. This action causes the current packet command to be aborted. The device will remain BUSY until the aborted operation has completed. Following an abort, data is assumed to be unaligned to word boundar-

ies, and the FPGA requires a new synchronization word prior to accepting any new packets.

To initiate an abort during a write operation, de-assert  $\overline{WRITE}$ . At the rising edge of CCLK, an abort is initiated, as shown in Figure 18.

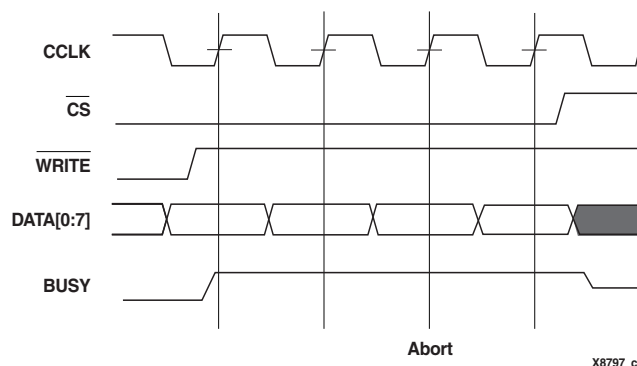


Figure 18: SelectMAP Write Abort Waveforms

## Boundary-Scan Mode

In the boundary-scan mode, configuration is done through the IEEE 1149.1 Test Access Port. Note that the PROGRAM pin must be pulled High prior to reconfiguration. A Low on the PROGRAM pin resets the TAP controller and no JTAG operations can be performed.

Configuration through the TAP uses the CFG\_IN instruction. This instruction allows data input on TDI to be converted into data packets for the internal configuration bus.

The following steps are required to configure the FPGA through the boundary-scan port (when using TCK as a start-up clock).

1. Load the CFG\_IN instruction into the boundary-scan instruction register (IR)
2. Enter the Shift-DR (SDR) state
3. Shift a configuration bitstream into TDI
4. Return to Run-Test-Idle (RTI)
5. Load the JSTART instruction into IR
6. Enter the SDR state
7. Clock TCK through the startup sequence
8. Return to RTI

Configuration and readback via the TAP is always available. The boundary-scan mode is selected by a <101> or 001> on the mode pins (M2, M1, M0). For details on TAP characteristics, refer to XAPP139.

## Configuration Sequence

The configuration of Virtex devices is a three-phase process. First, the configuration memory is cleared. Next, configuration data is loaded into the memory, and finally, the logic is activated by a start-up process.

Configuration is automatically initiated on power-up unless it is delayed by the user, as described below. The configuration process can also be initiated by asserting PROGRAM.

The end of the memory-clearing phase is signalled by INIT going High, and the completion of the entire process is signalled by DONE going High.

The power-up timing of configuration signals is shown in Figure 19. The corresponding timing characteristics are listed in Table 10.

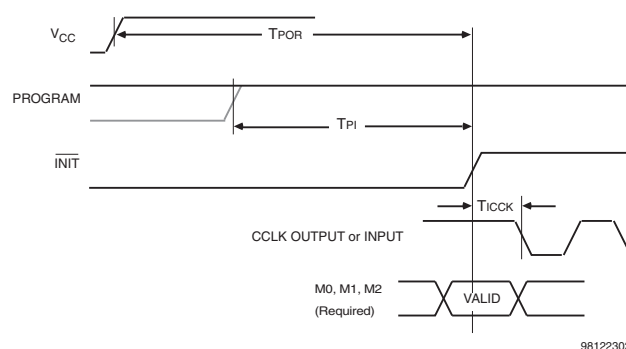


Figure 19: Power-Up Timing Configuration Signals

Table 10: Power-up Timing Characteristics

Description	Symbol	Value	Units
Power-on Reset	T <sub>POR</sub>	2.0	ms, max
Program Latency	T <sub>PL</sub>	100.0	μs, max
CCLK (output) Delay	T <sub>ICCK</sub>	0.5	μs, min
		4.0	μs, max
Program Pulse Width	T <sub>PROGRAM</sub>	300	ns, min

## Delaying Configuration

INIT can be held Low using an open-drain driver. An open-drain is required since INIT is a bidirectional open-drain pin that is held Low by the FPGA while the configuration memory is being cleared. Extending the time that the pin is Low causes the configuration sequencer to wait. Thus, configuration is delayed by preventing entry into the phase where data is loaded.

## Start-Up Sequence

The default Start-up sequence is that one CCLK cycle after DONE goes High, the global 3-state signal (GTS) is released. This permits device outputs to turn on as necessary.

One CCLK cycle later, the Global Set/Reset (GSR) and Global Write Enable (GWE) signals are released. This permits the internal storage elements to begin changing state in response to the logic and the user clock.

The relative timing of these events can be changed. In addition, the GTS, GSR, and GWE events can be made dependent on the DONE pins of multiple devices all going High, forcing the devices to start in synchronism. The sequence can also be paused at any stage until lock has been achieved on any or all DLLs.



### IOB Output Switching Characteristics Standard Adjustments

Output delays terminating at a pad are specified for LVTTTL with 12 mA drive and fast slew rate. For other standards, adjust the delays by the values shown.

Description	Symbol	Standard <sup>(1)</sup>	Speed Grade				Unit s
			Min	-6	-5	-4	
Output Delay Adjustments							
Standard-specific adjustments for output delays terminating at pads (based on standard capacitive load, Csl)	T <sub>OLVTTTL_S2</sub>	LVTTL, Slow, 2 mA	4.2	14.7	15.8	17.0	ns
	T <sub>OLVTTTL_S4</sub>	4 mA	2.5	7.5	8.0	8.6	ns
	T <sub>OLVTTTL_S6</sub>	6 mA	1.8	4.8	5.1	5.6	ns
	T <sub>OLVTTTL_S8</sub>	8 mA	1.2	3.0	3.3	3.5	ns
	T <sub>OLVTTTL_S12</sub>	12 mA	1.0	1.9	2.1	2.2	ns
	T <sub>OLVTTTL_S16</sub>	16 mA	0.9	1.7	1.9	2.0	ns
	T <sub>OLVTTTL_S24</sub>	24 mA	0.8	1.3	1.4	1.6	ns
	T <sub>OLVTTTL_F2</sub>	LVTTL, Fast, 2mA	1.9	13.1	14.0	15.1	ns
	T <sub>OLVTTTL_F4</sub>	4 mA	0.7	5.3	5.7	6.1	ns
	T <sub>OLVTTTL_F6</sub>	6 mA	0.2	3.1	3.3	3.6	ns
	T <sub>OLVTTTL_F8</sub>	8 mA	0.1	1.0	1.1	1.2	ns
	T <sub>OLVTTTL_F12</sub>	12 mA	0	0	0	0	ns
	T <sub>OLVTTTL_F16</sub>	16 mA	−0.10	−0.05	−0.05	−0.05	ns
	T <sub>OLVTTTL_F24</sub>	24 mA	−0.10	−0.20	−0.21	−0.23	ns
	T <sub>OLVCMOS2</sub>	LVC MOS2	0.10	0.10	0.11	0.12	ns
	T <sub>OPCI33_3</sub>	PCI, 33 MHz, 3.3 V	0.50	2.3	2.5	2.7	ns
	T <sub>OPCI33_5</sub>	PCI, 33 MHz, 5.0 V	0.40	2.8	3.0	3.3	ns
	T <sub>OPCI66_3</sub>	PCI, 66 MHz, 3.3 V	0.10	−0.40	−0.42	−0.46	ns
	T <sub>OGTL</sub>	GTL	0.6	0.50	0.54	0.6	ns
	T <sub>OGTLP</sub>	GTL+	0.7	0.8	0.9	1.0	ns
	T <sub>OHSTL_I</sub>	HSTL I	0.10	−0.50	−0.53	−0.5	ns
	T <sub>OHSTL_III</sub>	HSTL III	−0.10	−0.9	−0.9	−1.0	ns
	T <sub>OHSTL_IV</sub>	HSTL IV	−0.20	−1.0	−1.0	−1.1	ns
	T <sub>OSSTL2_I</sub>	SSTL2 I	−0.10	−0.50	−0.53	−0.5	ns
	T <sub>OSSTL2_II</sub>	SSTL2 II	−0.20	−0.9	−0.9	−1.0	ns
	T <sub>OSSTL3_I</sub>	SSTL3 I	−0.20	−0.50	−0.53	−0.5	ns
	T <sub>OSSTL3_II</sub>	SSTL3 II	−0.30	−1.0	−1.0	−1.1	ns
	T <sub>OCTT</sub>	CTT	0	−0.6	−0.6	−0.6	ns
	T <sub>OAGP</sub>	AGP	0	−0.9	−0.9	−1.0	ns

#### Notes:

- Output timing is measured at 1.4 V with 35 pF external capacitive load for LVTTTL. For other I/O standards and different loads, see [Table 2](#) and [Table 3](#).



## Calculation of $T_{i\text{oop}}$ as a Function of Capacitance

$T_{i\text{oop}}$  is the propagation delay from the O Input of the IOB to the pad. The values for  $T_{i\text{oop}}$  were based on the standard capacitive load ( $C_{sl}$ ) for each I/O standard as listed in Table 2.

Table 2: Constants for Calculating  $T_{i\text{oop}}$

Standard	Csl (pF)	fl (ns/pF)
LVTTL Fast Slew Rate, 2mA drive	35	0.41
LVTTL Fast Slew Rate, 4mA drive	35	0.20
LVTTL Fast Slew Rate, 6mA drive	35	0.13
LVTTL Fast Slew Rate, 8mA drive	35	0.079
LVTTL Fast Slew Rate, 12mA drive	35	0.044
LVTTL Fast Slew Rate, 16mA drive	35	0.043
LVTTL Fast Slew Rate, 24mA drive	35	0.033
LVTTL Slow Slew Rate, 2mA drive	35	0.41
LVTTL Slow Slew Rate, 4mA drive	35	0.20
LVTTL Slow Slew Rate, 6mA drive	35	0.100
LVTTL Slow Slew Rate, 8mA drive	35	0.086
LVTTL Slow Slew Rate, 12mA drive	35	0.058
LVTTL Slow Slew Rate, 16mA drive	35	0.050
LVTTL Slow Slew Rate, 24mA drive	35	0.048
LVCMS2	35	0.041
PCI 33MHz 5V	50	0.050
PCI 33MHZ 3.3 V	10	0.050
PCI 66 MHz 3.3 V	10	0.033
GTL	0	0.014
GTL+	0	0.017
HSTL Class I	20	0.022
HSTL Class III	20	0.016
HSTL Class IV	20	0.014
SSTL2 Class I	30	0.028
SSTL2 Class II	30	0.016
SSTL3 Class I	30	0.029
SSTL3 Class II	30	0.016
CTT	20	0.035
AGP	10	0.037

### Notes:

1. I/O parameter measurements are made with the capacitance values shown above. See Application Note XAPP133 on [www.xilinx.com](http://www.xilinx.com) for appropriate terminations.
2. I/O standard measurements are reflected in the IBIS model information except where the IBIS format precludes it.

For other capacitive loads, use the formulas below to calculate the corresponding  $T_{i\text{oop}}$ .

$$T_{i\text{oop}} = T_{i\text{oop}} + T_{\text{opadjust}} + (C_{\text{load}} - C_{sl}) * fl$$

Where:

$T_{\text{opadjust}}$  is reported above in the Output Delay Adjustment section.

$C_{\text{load}}$  is the capacitive load for the design.

Table 3: Delay Measurement Methodology

Standard	$V_L$ (1)	$V_H$ (1)	Meas. Point	$V_{REF}$ Typ (2)
LVTTL	0	3	1.4	-
LVCMS2	0	2.5	1.125	-
PCI33_5	Per PCI Spec			-
PCI33_3	Per PCI Spec			-
PCI66_3	Per PCI Spec			-
GTL	$V_{REF} - 0.2$	$V_{REF} + 0.2$	$V_{REF}$	0.80
GTL+	$V_{REF} - 0.2$	$V_{REF} + 0.2$	$V_{REF}$	1.0
HSTL Class I	$V_{REF} - 0.5$	$V_{REF} + 0.5$	$V_{REF}$	0.75
HSTL Class III	$V_{REF} - 0.5$	$V_{REF} + 0.5$	$V_{REF}$	0.90
HSTL Class IV	$V_{REF} - 0.5$	$V_{REF} + 0.5$	$V_{REF}$	0.90
SSTL3 I & II	$V_{REF} - 1.0$	$V_{REF} + 1.0$	$V_{REF}$	1.5
SSTL2 I & II	$V_{REF} - 0.75$	$V_{REF} + 0.75$	$V_{REF}$	1.25
CTT	$V_{REF} - 0.2$	$V_{REF} + 0.2$	$V_{REF}$	1.5
AGP	$V_{REF} - (0.2 \times V_{CCO})$	$V_{REF} + (0.2 \times V_{CCO})$	$V_{REF}$	Per AGP Spec

### Notes:

1. Input waveform switches between  $V_L$  and  $V_H$ .
2. Measurements are made at  $V_{REF}$  (Typ), Maximum, and Minimum. Worst-case values are reported.
3. I/O parameter measurements are made with the capacitance values shown in Table 2. See Application Note XAPP133 on [www.xilinx.com](http://www.xilinx.com) for appropriate terminations.
4. I/O standard measurements are reflected in the IBIS model information except where the IBIS format precludes it.

## I/O Standard Global Clock Input Adjustments

Description	Symbol	Standard <sup>(1)</sup>	Speed Grade				Units
			Min	-6	-5	-4	
Data Input Delay Adjustments							
Standard-specific global clock input delay adjustments	T <sub>GPLVTTL</sub>	LVTTL	0	0	0	0	ns, max
	T <sub>GPLVCMOS2</sub>	LVC MOS2	−0.02	−0.04	−0.04	−0.05	ns, max
	T <sub>GP PCI33_3</sub>	PCI, 33 MHz, 3.3 V	−0.05	−0.11	−0.12	−0.14	ns, max
	T <sub>GP PCI33_5</sub>	PCI, 33 MHz, 5.0 V	0.13	0.25	0.28	0.33	ns, max
	T <sub>GP PCI66_3</sub>	PCI, 66 MHz, 3.3 V	−0.05	−0.11	−0.12	−0.14	ns, max
	T <sub>GPGTL</sub>	GTL	0.7	0.8	0.9	0.9	ns, max
	T <sub>GPGTLP</sub>	GTL+	0.7	0.8	0.8	0.8	ns, max
	T <sub>GPHSTL</sub>	HSTL	0.7	0.7	0.7	0.7	ns, max
	T <sub>GPSSTL2</sub>	SSTL2	0.6	0.52	0.51	0.50	ns, max
	T <sub>GPSSTL3</sub>	SSTL3	0.6	0.6	0.55	0.54	ns, max
	T <sub>GPCTT</sub>	CTT	0.7	0.7	0.7	0.7	ns, max
	T <sub>GPAGP</sub>	AGP	0.6	0.54	0.53	0.52	ns, max

### Notes:

1. Input timing for GPLVTTL is measured at 1.4 V. For other I/O standards, see [Table 3](#).

## CLB Arithmetic Switching Characteristics

Setup times not listed explicitly can be approximated by decreasing the combinatorial delays by the setup time adjustment listed. Precise values are provided by the timing analyzer.

Description	Symbol	Speed Grade				Units
		Min	-6	-5	-4	
Combinatorial Delays						
F operand inputs to X via XOR	T <sub>OPX</sub>	0.37	0.8	0.9	1.0	ns, max
F operand input to XB output	T <sub>OPXB</sub>	0.54	1.1	1.3	1.4	ns, max
F operand input to Y via XOR	T <sub>OPY</sub>	0.8	1.5	1.7	2.0	ns, max
F operand input to YB output	T <sub>OPYB</sub>	0.8	1.5	1.7	2.0	ns, max
F operand input to COUT output	T <sub>OPCYF</sub>	0.6	1.2	1.3	1.5	ns, max
G operand inputs to Y via XOR	T <sub>OPGY</sub>	0.46	1.0	1.1	1.2	ns, max
G operand input to YB output	T <sub>OPGYB</sub>	0.8	1.6	1.8	2.1	ns, max
G operand input to COUT output	T <sub>OPCYG</sub>	0.7	1.3	1.4	1.6	ns, max
BX initialization input to COUT	T <sub>BXCY</sub>	0.41	0.9	1.0	1.1	ns, max
CIN input to X output via XOR	T <sub>CINX</sub>	0.21	0.41	0.46	0.53	ns, max
CIN input to XB	T <sub>CINXB</sub>	0.02	0.04	0.05	0.06	ns, max
CIN input to Y via XOR	T <sub>CINY</sub>	0.23	0.46	0.52	0.6	ns, max
CIN input to YB	T <sub>CINYB</sub>	0.23	0.45	0.51	0.6	ns, max
CIN input to COUT output	T <sub>BYP</sub>	0.05	0.09	0.10	0.11	ns, max
Multiplier Operation						
F1/2 operand inputs to XB output via AND	T <sub>FANDXB</sub>	0.18	0.36	0.40	0.46	ns, max
F1/2 operand inputs to YB output via AND	T <sub>FANDYB</sub>	0.40	0.8	0.9	1.1	ns, max
F1/2 operand inputs to COUT output via AND	T <sub>FANDCY</sub>	0.22	0.43	0.48	0.6	ns, max
G1/2 operand inputs to YB output via AND	T <sub>GANDYB</sub>	0.25	0.50	0.6	0.7	ns, max
G1/2 operand inputs to COUT output via AND	T <sub>GANDCY</sub>	0.07	0.13	0.15	0.17	ns, max
Setup and Hold Times before/after Clock CLK <sup>(1)</sup>	Setup Time / Hold Time					
CIN input to FFX	T <sub>CCKX</sub> /T <sub>CKCX</sub>	0.50 / 0	1.0 / 0	1.2 / 0	1.3 / 0	ns, min
CIN input to FFY	T <sub>CCKY</sub> /T <sub>CKCY</sub>	0.53 / 0	1.1 / 0	1.2 / 0	1.4 / 0	ns, min

### Notes:

1. A Zero "0" Hold Time listing indicates no hold time or a negative hold time. Negative values can not be guaranteed "best-case", but if a "0" is listed, there is no positive hold time.

## CLB SelectRAM Switching Characteristics

Description	Symbol	Speed Grade				Units
		Min	-6	-5	-4	
Sequential Delays						
Clock CLK to X/Y outputs (WE active) 16 x 1 mode	T <sub>SHCKO16</sub>	1.2	2.3	2.6	3.0	ns, max
Clock CLK to X/Y outputs (WE active) 32 x 1 mode	T <sub>SHCKO32</sub>	1.2	2.7	3.1	3.5	ns, max
Shift-Register Mode						
Clock CLK to X/Y outputs	T <sub>REG</sub>	1.2	3.7	4.1	4.7	ns, max
Setup and Hold Times before/after Clock CLK <sup>(1)</sup>	Setup Time / Hold Time					
F/G address inputs	T <sub>AS</sub> /T <sub>AH</sub>	0.25 / 0	0.5 / 0	0.6 / 0	0.7 / 0	ns, min
BX/BY data inputs (DIN)	T <sub>DS</sub> /T <sub>DH</sub>	0.34 / 0	0.7 / 0	0.8 / 0	0.9 / 0	ns, min
CE input (WE)	T <sub>WS</sub> /T <sub>WH</sub>	0.38 / 0	0.8 / 0	0.9 / 0	1.0 / 0	ns, min
Shift-Register Mode						
BX/BY data inputs (DIN)	T <sub>SHDICK</sub>	0.34	0.7	0.8	0.9	ns, min
CE input (WS)	T <sub>SHCECK</sub>	0.38	0.8	0.9	1.0	ns, min
Clock CLK						
Minimum Pulse Width, High	T <sub>WPH</sub>	1.2	2.4	2.7	3.1	ns, min
Minimum Pulse Width, Low	T <sub>WPL</sub>	1.2	2.4	2.7	3.1	ns, min
Minimum clock period to meet address write cycle time	T <sub>WC</sub>	2.4	4.8	5.4	6.2	ns, min
Shift-Register Mode						
Minimum Pulse Width, High	T <sub>SRPH</sub>	1.2	2.4	2.7	3.1	ns, min
Minimum Pulse Width, Low	T <sub>SRPL</sub>	1.2	2.4	2.7	3.1	ns, min

**Notes:**

1. A Zero "0" Hold Time listing indicates no hold time or a negative hold time. Negative values can not be guaranteed "best-case", but if a "0" is listed, there is no positive hold time.

## Minimum Clock-to-Out for Virtex Devices

I/O Standard	With DLL	Without DLL									
	All Devices	V50	V100	V150	V200	V300	V400	V600	V800	V1000	Units
*LVTTTL_S2	5.2	6.0	6.0	6.0	6.0	6.1	6.1	6.1	6.1	6.1	ns
*LVTTTL_S4	3.5	4.3	4.3	4.3	4.3	4.4	4.4	4.4	4.4	4.4	ns
*LVTTTL_S6	2.8	3.6	3.6	3.6	3.6	3.7	3.7	3.7	3.7	3.7	ns
*LVTTTL_S8	2.2	3.1	3.1	3.1	3.1	3.1	3.1	3.2	3.2	3.2	ns
*LVTTTL_S12	2.0	2.9	2.9	2.9	2.9	2.9	2.9	3.0	3.0	3.0	ns
*LVTTTL_S16	1.9	2.8	2.8	2.8	2.8	2.8	2.8	2.9	2.9	2.9	ns
*LVTTTL_S24	1.8	2.6	2.6	2.7	2.7	2.7	2.7	2.7	2.7	2.8	ns
*LVTTTL_F2	2.9	3.8	3.8	3.8	3.8	3.8	3.8	3.9	3.9	3.9	ns
*LVTTTL_F4	1.7	2.6	2.6	2.6	2.6	2.6	2.6	2.7	2.7	2.7	ns
*LVTTTL_F6	1.2	2.0	2.0	2.0	2.1	2.1	2.1	2.1	2.1	2.2	ns
*LVTTTL_F8	1.1	1.9	1.9	1.9	1.9	2.0	2.0	2.0	2.0	2.0	ns
*LVTTTL_F12	1.0	1.8	1.8	1.8	1.8	1.9	1.9	1.9	1.9	1.9	ns
*LVTTTL_F16	0.9	1.7	1.8	1.8	1.8	1.8	1.8	1.8	1.9	1.9	ns
*LVTTTL_F24	0.9	1.7	1.7	1.7	1.8	1.8	1.8	1.8	1.8	1.9	ns
LVCMS2	1.1	1.9	1.9	1.9	2.0	2.0	2.0	2.0	2.0	2.1	ns
PCI33_3	1.5	2.4	2.4	2.4	2.4	2.4	2.4	2.5	2.5	2.5	ns
PCI33_5	1.4	2.2	2.2	2.3	2.3	2.3	2.3	2.3	2.3	2.4	ns
PCI66_3	1.1	1.9	1.9	2.0	2.0	2.0	2.0	2.0	2.1	2.1	ns
GTL	1.6	2.5	2.5	2.5	2.5	2.5	2.5	2.6	2.6	2.6	ns
GTL+	1.7	2.5	2.5	2.6	2.6	2.6	2.6	2.6	2.6	2.7	ns
HSTL I	1.1	1.9	1.9	1.9	1.9	2.0	2.0	2.0	2.0	2.0	ns
HSTL III	0.9	1.7	1.7	1.8	1.8	1.8	1.8	1.8	1.8	1.9	ns
HSTL IV	0.8	1.6	1.6	1.6	1.7	1.7	1.7	1.7	1.7	1.8	ns
SSTL2 I	0.9	1.7	1.7	1.7	1.7	1.8	1.8	1.8	1.8	1.8	ns
SSTL2 II	0.8	1.6	1.6	1.6	1.6	1.7	1.7	1.7	1.7	1.7	ns
SSTL3 I	0.8	1.6	1.7	1.7	1.7	1.7	1.7	1.7	1.8	1.8	ns
SSTL3 II	0.7	1.5	1.5	1.6	1.6	1.6	1.6	1.6	1.6	1.7	ns
CTT	1.0	1.8	1.8	1.8	1.9	1.9	1.9	1.9	1.9	2.0	ns
AGP	1.0	1.8	1.8	1.9	1.9	1.9	1.9	1.9	1.9	2.0	ns

\*S = Slow Slew Rate, F = Fast Slew Rate

### Notes:

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. Input and output timing is measured at 1.4 V for LVTTTL. For other I/O standards, see [Table 3](#). In all cases, an 8 pF external capacitive load is used.

### Virtex Pin-to-Pin Input Parameter Guidelines

All devices are 100% functionally tested. Listed below are representative values for typical pin locations and normal clock loading. Values are expressed in nanoseconds unless otherwise noted

#### Global Clock Set-Up and Hold for LVTTL Standard, *with DLL*

Description	Symbol	Device	Speed Grade				Units
			Min	-6	-5	-4	
Input Setup and Hold Time Relative to Global Clock Input Signal for LVTTL Standard. For data input with different standards, adjust the setup time delay by the values shown in Input Delay Adjustments.							
No Delay Global Clock and IFF, with DLL	$T_{PSDLL}/T_{PHDLL}$	XCV50	0.40 / -0.4	1.7 / -0.4	1.8 / -0.4	2.1 / -0.4	ns, min
		XCV100	0.40 / -0.4	1.7 / -0.4	1.9 / -0.4	2.1 / -0.4	ns, min
		XCV150	0.40 / -0.4	1.7 / -0.4	1.9 / -0.4	2.1 / -0.4	ns, min
		XCV200	0.40 / -0.4	1.7 / -0.4	1.9 / -0.4	2.1 / -0.4	ns, min
		XCV300	0.40 / -0.4	1.7 / -0.4	1.9 / -0.4	2.1 / -0.4	ns, min
		XCV400	0.40 / -0.4	1.7 / -0.4	1.9 / -0.4	2.1 / -0.4	ns, min
		XCV600	0.40 / -0.4	1.7 / -0.4	1.9 / -0.4	2.1 / -0.4	ns, min
		XCV800	0.40 / -0.4	1.7 / -0.4	1.9 / -0.4	2.1 / -0.4	ns, min
		XCV1000	0.40 / -0.4	1.7 / -0.4	1.9 / -0.4	2.1 / -0.4	ns, min

IFF = Input Flip-Flop or Latch

#### Notes:

1. Set-up time is measured relative to the Global Clock input signal with the fastest route and the lightest load. Hold time is measured relative to the Global Clock input signal with the slowest route and heaviest load.
2. DLL output jitter is already included in the timing calculation.
3. A Zero "0" Hold Time listing indicates no hold time or a negative hold time. Negative values can not be guaranteed "best-case", but if a "0" is listed, there is no positive hold time.

### DLL Timing Parameters

All devices are 100 percent functionally tested. Because of the difficulty in directly measuring many internal timing parameters, those parameters are derived from benchmark timing patterns. The following guidelines reflect worst-case values across the recommended operating conditions.

Description	Symbol	Speed Grade						Units
		-6		-5		-4		
		Min	Max	Min	Max	Min	Max	
Input Clock Frequency (CLKDLLHF)	FCLKINHF	60	200	60	180	60	180	MHz
Input Clock Frequency (CLKDLL)	FCLKINLF	25	100	25	90	25	90	MHz
Input Clock Pulse Width (CLKDLLHF)	T <sub>DLLPWHF</sub>	2.0	-	2.4	-	2.4	-	ns
Input Clock Pulse Width (CLKDLL)	T <sub>DLLPWL</sub>	2.5	-	3.0		3.0	-	ns

#### Notes:

1. All specifications correspond to Commercial Operating Temperatures (0°C to +85°C).

### DLL Clock Tolerance, Jitter, and Phase Information

All DLL output jitter and phase specifications determined through statistical measurement at the package pins using a clock mirror configuration and matched drivers.

Description	Symbol	F <sub>CLKIN</sub>	CLKDLLHF		CLKDLL		Units
			Min	Max	Min	Max	
Input Clock Period Tolerance	T <sub>IP</sub> TOL		-	1.0	-	1.0	ns
Input Clock Jitter Tolerance (Cycle to Cycle)	T <sub>IJ</sub> TCC		-	± 150	-	± 300	ps
Time Required for DLL to Acquire Lock	T <sub>LOCK</sub>	> 60 MHz	-	20	-	20	μs
		50 - 60 MHz	-	-	-	25	μs
		40 - 50 MHz	-	-	-	50	μs
		30 - 40 MHz	-	-	-	90	μs
		25 - 30 MHz	-	-	-	120	μs
Output Jitter (cycle-to-cycle) for any DLL Clock Output <sup>(1)</sup>	T <sub>OJ</sub> TCC			± 60		± 60	ps
Phase Offset between CLKIN and CLKO <sup>(2)</sup>	T <sub>PHIO</sub>			± 100		± 100	ps
Phase Offset between Clock Outputs on the DLL <sup>(3)</sup>	T <sub>PHOO</sub>			± 140		± 140	ps
Maximum Phase Difference between CLKIN and CLKO <sup>(4)</sup>	T <sub>PHIOM</sub>			± 160		± 160	ps
Maximum Phase Difference between Clock Outputs on the DLL <sup>(5)</sup>	T <sub>PHOOM</sub>			± 200		± 200	ps

#### Notes:

1. **Output Jitter** is cycle-to-cycle jitter measured on the DLL output clock, *excluding* input clock jitter.
2. **Phase Offset between CLKIN and CLKO** is the worst-case fixed time difference between rising edges of CLKIN and CLKO, *excluding* Output Jitter and input clock jitter.
3. **Phase Offset between Clock Outputs on the DLL** is the worst-case fixed time difference between rising edges of any two DLL outputs, *excluding* Output Jitter and input clock jitter.
4. **Maximum Phase Difference between CLKIN and CLKO** is the sum of Output Jitter and Phase Offset between CLKIN and CLKO, or the greatest difference between CLKIN and CLKO rising edges due to DLL alone (*excluding* input clock jitter).
5. **Maximum Phase Difference between Clock Outputs on the DLL** is the sum of Output Jitter and Phase Offset between any two DLL clock outputs, or the greatest difference between any two DLL output rising edges due to DLL alone (*excluding* input clock jitter).
6. All specifications correspond to Commercial Operating Temperatures (0°C to +85°C).



Table 2: Virtex Pinout Tables (Chip-Scale and QFP Packages) (Continued)

Pin Name	Device	CS144	TQ144	PQ/HQ240
<b>V<sub>REF</sub> Bank 3</b> (V <sub>REF</sub> pins are listed incrementally. Connect all pins listed for both the required device and all smaller devices listed in the same package.) Within each bank, if input reference voltage is not required, all V <sub>REF</sub> pins are general I/O.	XCV50	H11, K12	60, 68	130, 144
	XCV100/150	... + J10	... + 66	... + 133
	XCV200/300	N/A	N/A	... + 126
	XCV400	N/A	N/A	... + 147
	XCV600	N/A	N/A	... + 132
	XCV800	N/A	N/A	... + 140
<b>V<sub>REF</sub> Bank 4</b> (V <sub>REF</sub> pins are listed incrementally. Connect all pins listed for both the required device and all smaller devices listed in the same package.) Within each bank, if input reference voltage is not required, all V <sub>REF</sub> pins are general I/O.	XCV50	L8, L10	79, 87	97, 111
	XCV100/150	... + N10	... + 81	... + 108
	XCV200/300	N/A	N/A	... + 115
	XCV400	N/A	N/A	... + 94
	XCV600	N/A	N/A	... + 109
	XCV800	N/A	N/A	... + 101
<b>V<sub>REF</sub> Bank 5</b> (V <sub>REF</sub> pins are listed incrementally. Connect all pins listed for both the required device and all smaller devices listed in the same package.) Within each bank, if input reference voltage is not required, all V <sub>REF</sub> pins are general I/O.	XCV50	L4, L6	96, 104	70, 84
	XCV100/150	... + N4	... + 102	... + 73
	XCV200/300	N/A	N/A	... + 66
	XCV400	N/A	N/A	... + 87
	XCV600	N/A	N/A	... + 72
	XCV800	N/A	N/A	... + 80

Table 3: Virtex Pinout Tables (BGA) (Continued)

Pin Name	Device	BG256	BG352	BG432	BG560
<b>V<sub>CCINT</sub></b> <b>Notes:</b> <ul style="list-style-type: none"> <li>Superset includes all pins, including the ones in <b>bold</b> type. Subset excludes pins in <b>bold</b> type.</li> <li>In BG352, for XCV300 all the V<sub>CCINT</sub> pins in the superset must be connected. For XCV150/200, V<sub>CCINT</sub> pins in the subset must be connected, and pins in <b>bold</b> type can be left unconnected (these unconnected pins cannot be used as user I/O.)</li> <li>In BG432, for XCV400/600/800 all V<sub>CCINT</sub> pins in the superset must be connected. For XCV300, V<sub>CCINT</sub> pins in the subset must be connected, and pins in <b>bold</b> type can be left unconnected (these unconnected pins cannot be used as user I/O.)</li> <li>In BG560, for XCV800/1000 all V<sub>CCINT</sub> pins in the superset must be connected. For XCV400/600, V<sub>CCINT</sub> pins in the subset must be connected, and pins in <b>bold</b> type can be left unconnected (these unconnected pins cannot be used as user I/O.)</li> </ul>	XCV50/100	C10, D6, D15, F4, F17, L3, L18, R4, R17, U6, U15, V10	N/A	N/A	N/A
	XCV150/200/300	Same as above	A20, C14, D10, J24, K4, P2, P25, V24, W2, AC10, AE14, AE19, <b>B16, D12, L1, L25, R23, T1, AF11, AF16</b>	A10, A17, B23, C14, C19, K3, K29, N2, N29, T1, T29, W2, W31, AB2, AB30, AJ10, AJ16, AK13, AK19, AK22, <b>B26, C7, F1, F30, AE29, AF1, AH8, AH24</b>	N/A
	XCV400/600/800/1000	N/A	N/A	Same as above	A21, B14, B18, B28, C24, E9, E12, F2, H30, J1, K32, N1, N33, U5, U30, Y2, Y31, AD2, AD32, AG3, AG31, AK8, AK11, AK17, AK20, AL14, AL27, AN25, <b>B12, C22, M3, N29, AB2, AB32, AJ13, AL22</b>
V <sub>CCO</sub> , Bank 0	All	D7, D8	A17, B25, D19	A21, C29, D21	A22, A26, A30, B19, B32
V <sub>CCO</sub> , Bank 1	All	D13, D14	A10, D7, D13	A1, A11, D11	A10, A16, B13, C3, E5
V <sub>CCO</sub> , Bank 2	All	G17, H17	B2, H4, K1	C3, L1, L4	B2, D1, H1, M1, R2
V <sub>CCO</sub> , Bank 3	All	N17, P17	P4, U1, Y4	AA1, AA4, AJ3	V1, AA2, AD1, AK1, AL2
V <sub>CCO</sub> , Bank 4	All	U13, U14	AC8, AE2, AF10	AH11, AL1, AL11	AM2, AM15, AN4, AN8, AN12
V <sub>CCO</sub> , Bank 5	All	U7, U8	AC14, AC20, AF17	AH21, AJ29, AL21	AL31, AM21, AN18, AN24, AN30
V <sub>CCO</sub> , Bank 6	All	N4, P4	U26, W23, AE25	AA28, AA31, AL31	W32, AB33, AF33, AK33, AM32

Table 3: Virtex Pinout Tables (BGA) (Continued)

Pin Name	Device	BG256	BG352	BG432	BG560
<b>V<sub>REF</sub> Bank 7</b> (V <sub>REF</sub> pins are listed incrementally. Connect all pins listed for both the required device and all smaller devices listed in the same package.) Within each bank, if input reference voltage is not required, all V <sub>REF</sub> pins are general I/O.	XCV50	G3, H1	N/A	N/A	N/A
	XCV100/150	... + D1	D26, G26, L26	N/A	N/A
	XCV200/300	... + B2	... + E24	F28, F31, J30, N30	N/A
	XCV400	N/A	N/A	... + R31	E31, G31, K31, P31, T31
	XCV600	N/A	N/A	... + J28	... + H32
	XCV800	N/A	N/A	... + M28	... + L33
	XCV1000	N/A	N/A	N/A	... + D31
GND	All	C3, C18, D4, D5, D9, D10, D11, D12, D16, D17, E4, E17, J4, J17, K4, K17, L4, L17, M4, M17, T4, T17, U4, U5, U9, U10, U11, U12, U16, U17, V3, V18	A1, A2, A5, A8, A14, A19, A22, A25, A26, B1, B26, E1, E26, H1, H26, N1, P26, W1, W26, AB1, AB26, AE1, AE26, AF1, AF2, AF5, AF8, AF13, AF19, AF22, AF25, AF26	A2, A3, A7, A9, A14, A18, A23, A25, A29, A30, B1, B2, B30, B31, C1, C31, D16, G1, G31, J1, J31, P1, P31, T4, T28, V1, V31, AC1, AC31, AE1, AE31, AH16, AJ1, AJ31, AK1, AK2, AK30, AK31, AL2, AL3, AL7, AL9, AL14, AL18, AL23, AL25, AL29, AL30	A1, A7, A12, A14, A18, A20, A24, A29, A32, A33, B1, B6, B9, B15, B23, B27, B31, C2, E1, F32, G2, G33, J32, K1, L2, M33, P1, P33, R32, T1, V33, W2, Y1, Y33, AB1, AC32, AD33, AE2, AG1, AG32, AH2, AJ33, AL32, AM3, AM7, AM11, AM19, AM25, AM28, AM33, AN1, AN2, AN5, AN10, AN14, AN16, AN20, AN22, AN27, AN33
GND <sup>(1)</sup>	All	J9, J10, J11, J12, K9, K10, K11, K12, L9, L10, L11, L12, M9, M10, M11, M12	N/A	N/A	N/A
No Connect	All	N/A	N/A	N/A	C31, AC2, AK4, AL3

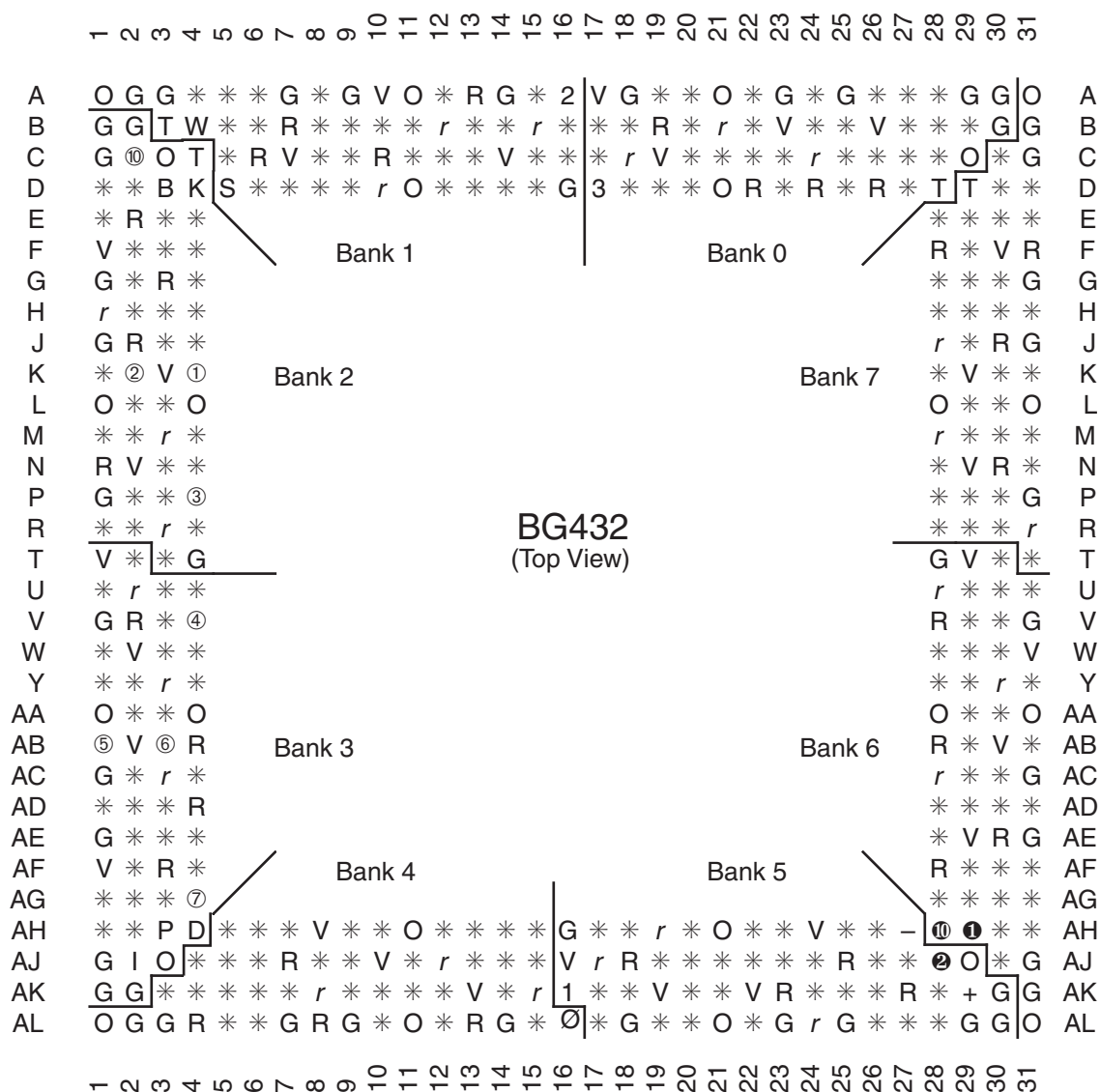
**Notes:**

1. 16 extra balls (grounded) at package center.

*Table 4: Virtex Pinout Tables (Fine-Pitch BGA) (Continued)*

Pin Name	Device	FG256	FG456	FG676	FG680
V <sub>CCINT</sub>	All	C3, C14, D4, D13, E5, E12, M5, M12, N4, N13, P3, P14	E5, E18, F6, F17, G7, G8, G9, G14, G15, G16, H7, H16, J7, J16, P7, P16, R7, R16, T7, T8, T9, T14, T15, T16, U6, U17, V5, V18	G7, G20, H8, H19, J9, J10, J11, J16, J17, J18, K9, K18, L9, L18, T9, T18, U9, U18, V9, V10, V11, V16, V17, V18, W8, W19, Y7, Y20	AD5, AD35, AE5, AE35, AL5, AL35, AM5, AM35, AR8, AR9, AR15, AR16, AR24, AR25, AR31, AR32, E8, E9, E15, E16, E24, E25, E31, E32, H5, H35, J5, J35, R5, R35, T5, T35
V <sub>CCO</sub> , Bank 0	All	E8, F8	F7, F8, F9, F10, G10, G11	H9, H10, H11, H12, J12, J13	E26, E27, E29, E30, E33, E34
V <sub>CCO</sub> , Bank 1	All	E9, F9	F13, F14, F15, F16, G12, G13	H15, H16, H17, H18, J14, J15	E6, E7, E10, E11, E13, E14
V <sub>CCO</sub> , Bank 2	All	H11, H12	G17, H17, J17, K16, K17, L16	J19, K19, L19, M18, M19, N18	F5, G5, K5, L5, N5, P5
V <sub>CCO</sub> , Bank 3	All	J11, J12	M16, N16, N17, P17, R17, T17	P18, R18, R19, T19, U19, V19	AF5, AG5, AN5, AK5, AJ5, AP5
V <sub>CCO</sub> , Bank 4	All	L9, M9	T12, T13, U13, U14, U15, U16,	V14, V15, W15, W16, W17, W18	AR6, AR7, AR10, AR11, AR13, AR14
V <sub>CCO</sub> , Bank 5	All	L8, M8	T10, T11, U7, U8, U9, U10	V12, V13, W9, W10, W11, W12	AR26, AR27, AR29, AR30, AR33, AR34
V <sub>CCO</sub> , Bank 6	All	J5, J6	M7, N6, N7, P6, R6, T6	P9, R8, R9, T8, U8, V8	AF35, AG35, AJ35, AK35, AN35, AP35
V <sub>CCO</sub> , Bank 7	All	H5, H6	G6, H6, J6, K6, K7, L7	J8, K8, L8, M8, M9, N9	F35, G35, K35, L35, N35, P35
V <sub>REF</sub> , Bank 0 (VREF pins are listed incrementally. Connect all pins listed for both the required device and all smaller devices listed in the same package.) Within each bank, if input reference voltage is not required, all V <sub>REF</sub> pins are general I/O.	XCV50	B4, B7	N/A	N/A	N/A
	XCV100/150	... + C6	A9, C6, E8	N/A	N/A
	XCV200/300	... + A3	... + B4	N/A	N/A
	XCV400	N/A	N/A	A12, C11, D6, E8, G10	
	XCV600	N/A	N/A	... + B7	A33, B28, B30, C23, C24, D33
	XCV800	N/A	N/A	... + B10	... + A26
	XCV1000	N/A	N/A	N/A	... + D34

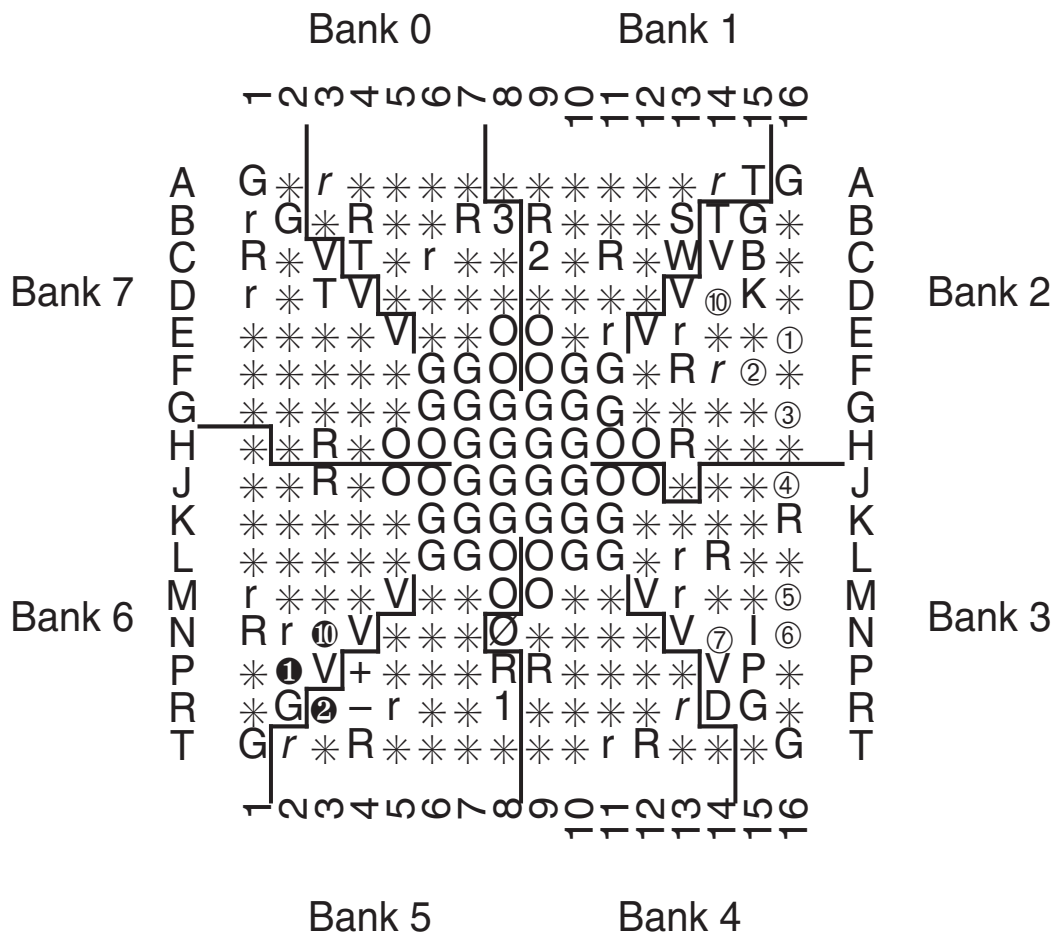
## BG432 Pin Function Diagram



DS003\_21\_100300

Figure 6: BG432 Pin Function Diagram

## FG256 Pin Function Diagram



**FG256**  
(Top view)

**Figure 8: FG256 Pin Function Diagram**